•	Search Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/517,893	KOUTONEN ET AL.	
Examiner	Art Unit	
SANG KIM	3654	

SEARCHED				
Class	Subclass	Date	Examiner	
242	534 541 542	3/18/2007	SK	
242	542.2	3/18/2007	SK	
242	542.4	3/18/2007	SK	
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INT	INTERFERENCE SEARCHED			
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		DATE	EXMR
John Nguyen: 242/541, 542		3/18/2007	SK
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